EE709 End-semester exam. To be submitted by 8 May, 2021 2355

This is a take-home exam. You are expected to solve it *by yourself*, using reference material provided in class.

- 1. You are asked to implement a *majority* function on 5 input variables. The output of the function is 1 if and only if at least 3 of the inputs are 1.
 - (a) Implement the function using only 2-input NAND gates (3 marks).
 - (b) Implement the function using only 2-input NOR gates (3 marks).
 - (c) Implement the function using only 2-to-1 multiplexors (4 marks).

In each case, you are expected to draw the final circuit diagram.

2. Consider the following system of boolean functions:

$$y_1 = x_1 \oplus x_2 \oplus x_3 \oplus x_4$$

$$y_2 = (x_1.x_2) \oplus (x_2.x_3) \oplus (x_3.x_4) \oplus (x_1.x_4)$$

$$y_3 = (x_1.x_2.x_3) \oplus (x_2.x_3.x_4) \oplus (x_1.x_3.x_4)$$

This describes a function from \mathbf{B}_2^4 to \mathbf{B}_2^3 .

- (a) Let A be the set defined by the formula $(x_1.x_2) + (x_3.x_4)$. Using the BDD package, find the image of A under this function. (5 marks)
- (b) Let B be the set defined by the formula $(y_1.y_2) + (y_2.y_3)$. Using the BDD package, find the pre-image of B under this function. (5 marks)

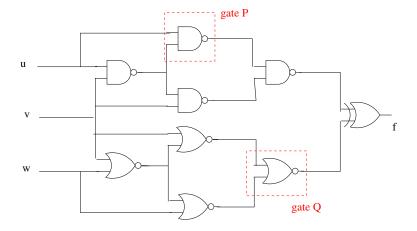


Figure 1: Test generation.

In each case, submit you code together with the generated output.

- 3. Consider the circuit shown in Figure 1. In this circuit, there are two possible faults that can occur. In the first fault, the NAND gate P can behave like a NOR gate. In the second fault, the NOR gate Q can behave like a NAND gate. Using the MINISAT package, find tests to detect each of these faults. Submit your code and run logs. (5 + 5).
- 4. Consider the Mealy state machine described by the following equations:

$$q_0(k+1) = x_1(k) \oplus x_2(k) \oplus q_1(k)$$

$$q_1(k+1) = x_2(k) \oplus q_0(k)$$

$$y(k) = x_1(k) + (q_0(k) \oplus q_1(k))$$

Assume that $q_0(0) = q_1(0) = 0$.

- (a) Find (using the BDD package) the set of reachable states starting from this initial state. (5 marks)
- (b) Using the MINISAT package, determine if the following sequence of output values (at y) can occur in this state machine? If yes, find an input sequence (at x_1 and x_2) which creates this output sequence. (5 marks)

In each case, submit your code and run logs.

5. Write a short essay (300 words) outlining the concepts of defects, fault models and errors in CMOS circuits. (10)